

# RL78/G22

## RL78/G22 Capacitive Touch Evaluation System Sample Code

### Introduction

This document describes the sample code for the RL78/G22 Capacitive Touch Evaluation System

### Target Device

RL78/G22 (R7F102GGE2DFB)

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## 1. Overview

This sample code is software that operates with capacitive touch in the RX140 Capacitive Touch Evaluation system.

The following is added to the project created by e2 studio.

- Components generated by the Smart Configurator
- Capacitive touch configuration files and applications tuning with QE for Capacitive Touch (QE)
- LED control application

### 1.1 Function

The functions are shown below.

1. Capacitive touch function operates all electrodes (3 buttons, slider, wheel, shield) of Capacitive Touch Evaluation Application Board.
2. Enables USB serial interface to control serial communication and supports QE serial monitor and serial tuning. For more information on serial monitoring and serial tuning, refer to "8. [Additional function] Setting the serial communication monitor using UART" in ["Application Note RL78 Family Using QE and SIS to Develop Capacitive Touch Applications \(R01AN5512\)"](#).
3. "LED control linked to capacitive touch buttons, sliders and wheels" and "LED control linked to CPU board push buttons" can be switched by setting SW6 on the CPU board and build option: RL78G22\_RSSK\_TEST. This is because some of the LED control ports on the electrode board and the LED control ports on the CPU board use the same GPIO pins.  
The initial setting performs LED control linked with capacitive touch buttons, sliders, and wheels.

- (1). LED control linked to capacitive touch buttons, sliders and wheels

Set SW6 on the CPU board to the left.

Set the build option: RL78G22\_RSSK\_TEST in qe\_touch\_sample.c as follows.

```
#define RL78G22_RSSK_TEST (ELCTRODE_BOARD)
```

- (2). LED control linked to CPU board push buttons

Pressing SW2, LED 2 lights up. Pressing SW3, LED3 lights up.

Set SW6 on the CPU board to the right.

Set the build option: RL78G22\_RSSK\_TEST in qe\_touch\_sample.c as follows.

```
#define RL78G22_RSSK_TEST (CPU_BOARD)
```

**Table 1-1 Settings by LED Control Function**

| No  | Function  | SW6 Setting | RL78G22_RSSK_TEST |
|-----|---|-------------|-------------------|
| (1) | LED control linked to capacitive touch<br>(Default setting) | Left        | ELCTRODE_BOARD    |
| (2) | LED control linked to CPU board push buttons                | Right       | CPU_BOARD         |

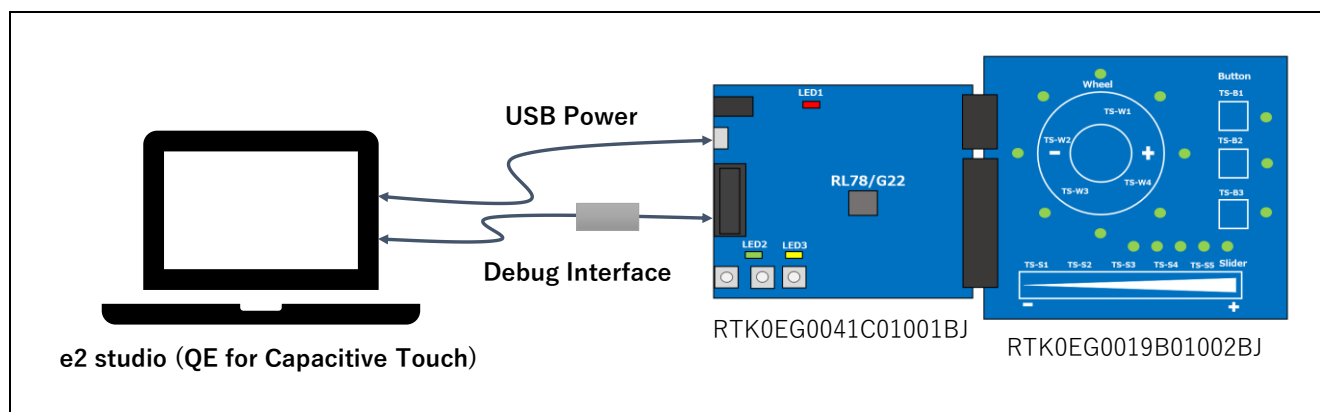
## 2. Operation confirmation conditions

The operation of this sample code has been confirmed the following environment.

**Table 2-1 Operation confirmation conditions**

| Item   | Description   |
|--|---|
| MCU  | RL78/G22 (R7F102GGE2DFB)  |
| Operating frequency                                      | 32MHz (HOCO 32MHz)  |
| Operating voltage  | 5V (USB power)  |
| Evaluation board   | RL78/G22 Capacitive Touch Evaluation System<br>(Product No : RTK0EG0042S01001BJ)<br><ul style="list-style-type: none"> <li>RL78/G22 CPU Board (Product No : RTK0EG0041C01001B)</li> <li>Capacitive Touch Evaluation Application Board<br/>— Self-Capacitance Buttons / Wheel / Slider Board<br/>(Product No: RTK0EG0019B01002BJ)</li> </ul> |
| Integrated development environment                       | Renesas e <sup>2</sup> studio Version 2023-01 (23.01.0)   |
| C Compiler   | Renesas CC-RL V1.12   |
| Development Assistance Tool for Capacitive Touch Sensors | QE for Capacitive Touch V3.2.0  |
| Emulator   | Renesas E2 Emulator Lite  |

Figure 2-1 shows device connection diagram

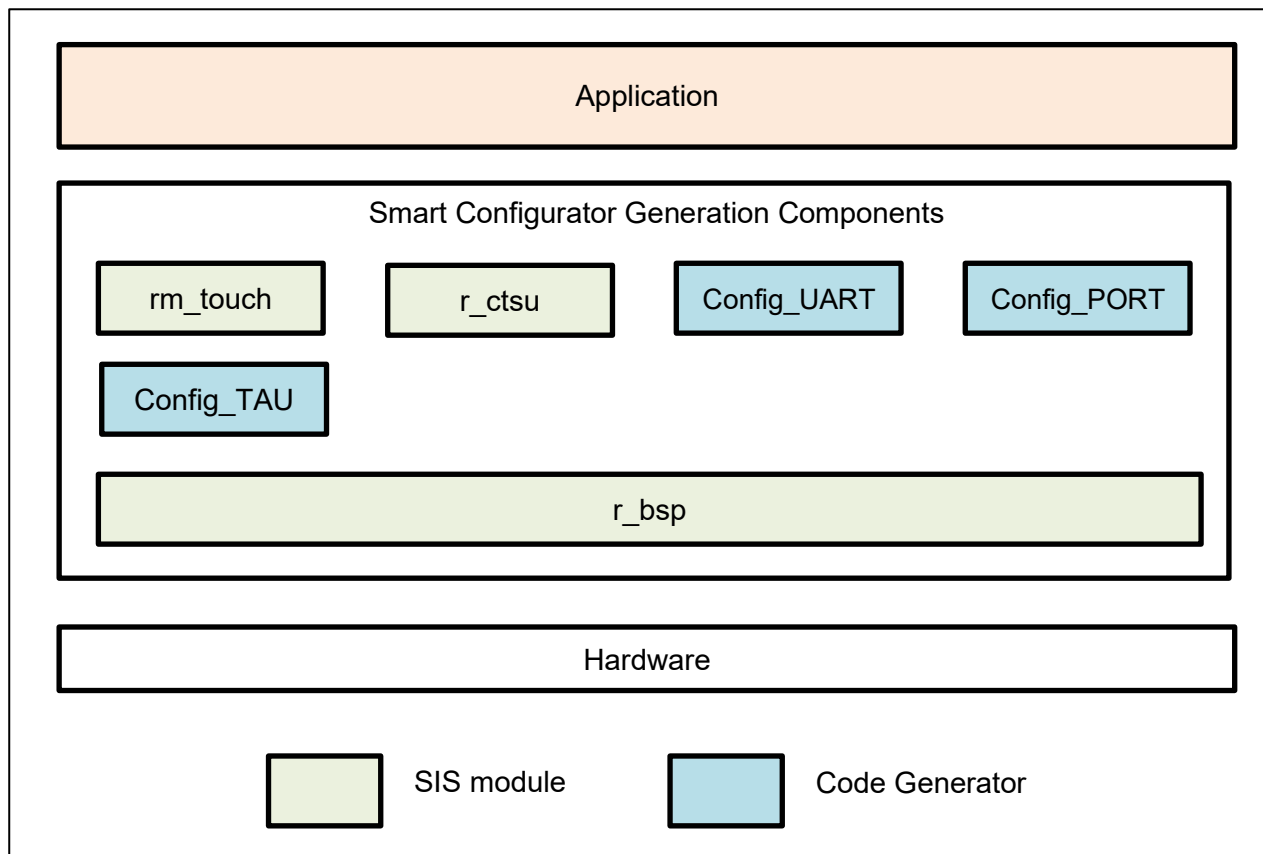


**Figure 2-1 Device Connection Diagram**

### 3. Software specification

#### 3.1 Software structure diagram

Figure 3-1 shows the software structure diagram of this sample code. This software uses components generated by the Smart Configurator.



**Figure 3-1 Software structure diagram**

Table 3-1 shows a list of components and versions. Refer to the smart configurator for component settings.

**Table 3-1 Components and versions list**

| Component                                  | Version | Configuration               |
|--|---------|-----------------------------|
| ✔ Board Support Packages. - v1.40 (r_bsp)  | 1.40    | r_bsp(used)                 |
| ✔ Capacitive Sensing Unit driver. (r_ctsu) | 1.30    | r_ctsu(used)                |
| ✔ Interval Timer                           | 1.3.0   | Config_TAU0_0(TAU0_0: used) |
| ✔ Ports                                    | 1.3.0   | Config_PORT(PORT: used)     |
| ✔ Touch middleware. (rm_touch)             | 1.30    | rm_touch(used)              |
| ✔ UART Communication                       | 1.4.0   | Config_UART1(UART1: used)   |
|  |         |                             |

### 3.2 File structure

This is the file structure of this sample code. The project configuration file and smart configurator generation file of the development environment are omitted.

rl78g22\_rssk\_sample

|                             |   |
|-----------------------------|---|
| QE-Touch                    |   |
| qe_tuning20230208091730.log | • • • QE Tuning log                       |
| rl78g22_rssk_sample.tifcfg  | • • • Touch interface configuration file  |
| qe_gen                      |   |
| qe_touch_config.c           | • • • Touch configuration source          |
| qe_touch_config.h           | • • • Touch configuration header          |
| qe_touch_define.h           | • • • Touch define header                 |
| qe_touch_sample.c           | • • • Touch sample application            |
| src                         |   |
| rl78g22_rssk_sample.c       | • • • Main file                           |
| r_rssk_switch_led.c         | • • • Switch & LED function source        |
| r_rssk_switch_led.h         | • • • Switch & LED function header        |
| r_rssk_touch_led.c          | • • • Touch electrode LED function source |
| r_rssk_touch_led.h          | • • • Touch electrode LED function header |
| smc_gen                     |   |
| Config_PORT                 | • • • PORT driver folder                  |
| Config_TAU0_0               | • • • Timer driver folder                 |
| Config_UART1                | • • • UART driver folder                  |
| general                     | • • • general setting folder              |
| rm_touch                    | • • • TOUCH SIS module folder             |
| r_bsp                       | • • • BSP folder                          |
| r_config                    | • • • SIS config folder                   |
| r_ctsu                      | • • • CTSU SIS module folder              |
| r_pincfg                    | • • • Pin config folder                   |

### 3.3 Constants

Table 3-2 lists the constants.

**Table 3-2 List of Constant**

| Constant Name                          | Setting Value    | Description  |
|--|------------------|--|
| <b>File Name : qe_touch_sample.c</b>   |                  |  |
| RL78G22_RSSK_TEST                      | (ELCTRODE_BOARD) | Change the LED control target by specifying ELCTRODE_BOARD or CPU_BOARD.                                 |
| ELCTRODE_BOARD                         | (0)              | By setting RL78G22_RSSK_TEST, the Self-Capacitance Buttons / Wheel / Slider Board LED can be controlled. |
| CPU_BOARD                              | (1)              | By setting RL78G22_RSSK_TEST, the CPU board LED can be controlled.                                       |
| TOUCH_SCAN_INTERVAL_EXAMPLE            | (20 * 1000)      | Software delay value<br>[unit: $\mu$ s]  |
| TEST_INTERVAL_EXAMPLE                  | (1 * 1000)       | Initial LED software delay value<br>[unit: $\mu$ s]  |
| <b>File Name : r_rssk_switch_led.c</b> |                  |  |
| RSSK_SW2_PORT                          | (P6_bit.no1)     | Pointer to port control register connected to SW2  |
| RSSK_SW3_PORT                          | (P6_bit.no0)     | Pointer to port control register connected to SW3  |
| RSSK_LED2_PORT                         | (P6_bit.no2)     | Pointer to port control register connected to LED2   |
| RSSK_LED3_PORT                         | (P6_bit.no3)     | Pointer to port control register connected to LED3   |
| SW_EDGE_RIZE                           | (0x07U)          | Switch rising judgment   |
| SW_EDGE_FALL                           | (0x08U)          | Switch falling judgment  |
| SW_EDGE_BIT_MASK                       | (0x0FU)          | Switch state judgement mask  |
| RSSK_LED_ON                            | (0x00U)          | Turn on the LED  |
| RSSK_LED_OFF                           | (0x01U)          | Turn off the LED   |

**List of Constant (Continue)**

| File Name : r_rssk_touch_led.c |                             |  |
|--------------------------------|-----------------------------|--|
| LED_COL0                       | (P12_bit.no1)               | Pointer to port control register connected to COL0 |
| LED_COL1                       | (P12_bit.no2)               | Pointer to port control register connected to COL1 |
| LED_COL2                       | (P6_bit.no1)                | Pointer to port control register connected to COL2 |
| LED_COL3                       | (P6_bit.no2)                | Pointer to port control register connected to COL3 |
| LED_ROW0                       | (P2_bit.no0)                | Pointer to port control register connected to ROW0 |
| LED_ROW1                       | (P2_bit.no1)                | Pointer to port control register connected to ROW1 |
| LED_ROW2                       | (P4_bit.no1)                | Pointer to port control register connected to ROW2 |
| LED_ROW3                       | (P12_bit.no0)               | Pointer to port control register connected to ROW3 |
| LED_COL_MAX                    | (4U)                        | Number of COL signals                              |
| LED_COL_ON                     | (0x01U)                     | COL signal ON                                      |
| LED_COL_OFF                    | (0x00U)                     | COL signal OFF                                     |
| LED_ROW_OFF                    | (0x01U)                     | ROW signal OFF                                     |
| SLIDER_LED_NUM                 | (5U)                        | Number of slider LED                               |
| SLIDER_RESOLUTION              | (100U)                      | Maximum slider touch result                        |
| WHEEL_LED_NUM                  | (8U)                        | Number of wheel LED                                |
| WHEEL_LED_MSB                  | (1U << (WHEEL_LED_NUM - 1)) | Wheel LED control bit MSB                          |
| WHEEL_RESOLUTION_DEGREE        | (360U)                      | Maximum wheel touch result<br>[unit : degree]      |
| WHEEL_POSITION_OFFSET_DEGREE   | (112U)                      | Wheel touch position offset<br>[unit : degree]     |
| ALL_LED_NUM                    | (16U)                       | Total number of touch electrode board LEDs         |
| LED_TEST_INTERVAL              | (100U)                      | LED lighting interval time                         |

**3.4 Enumerations**

Table 3-3 lists the rsk\_sw\_status\_t enum.

**Table 3-3 rsk\_sw\_status\_t**

| Member      | Value | Description      |
|-------------|-------|------------------|
| RSSK_SW_OFF | 0x00  | Switch OFF state |
| RSSK_SW_ON  | 0x01  | Switch ON state  |

### 3.5 Global Variables

Table 3-4 lists the global variables.

**Table 3-4 List of Global Variable**

| Variable Name                          | Types    | Description                                 |
|--|----------|---|
| <b>File Name : qe_touch_sample.c</b>   |          |   |
| button_status                          | uint64_t | Button status                               |
| slider_position[1]                     | uint16_t | Slider touch position information           |
| wheel_position[1]                      | uint16_t | Wheel touch position information            |
| <b>File Name : r_rssk_switch_led.c</b> |          |   |
| rssk_get_sw2_status                    | uint8_t  | State of switch SW2                         |
| rssk_get_sw3_status                    | uint8_t  | State of switch SW3                         |
| <b>File Name : r_rssk_touch_led.c</b>  |          |   |
| g_led_drive_colmun                     | uint8_t  | Touch electrode board LED drive information |
| g_button_idx[3]                        | uint8_t  | Button index array                          |

### 3.6 Functions

Table 3-5 lists the functions.

**Table 3-5 List of Function**

| Function Name                          | Description   |
|--|---|
| <b>File Name : qe_touch_sample.c</b>   |   |
| qe_touch_main                          | Main function   |
| qe_touch_delay                         | Software delay  |
| r_rssk_initialize                      | Initialization processing of Capacitive Touch Evaluation System |
| r_rssk_led_test                        | LED test processing for Capacitive Touch Evaluation System      |
| r_rssk_timer_callback                  | TAU0 interrupt callback   |
| <b>File Name : r_rssk_switch_led.c</b> |   |
| r_rssk_switch_led_init                 | CPU board LED initialization processing                         |
| r_rssk_switch_led_control              | CPU board LED control processing                                |
| r_rssk_led2_on                         | CPU board LED2 turn on  |
| r_rssk_led2_off                        | CPU board LED2 turn off   |
| r_rssk_led3_on                         | CPU board LED3 turn on  |
| r_rssk_led3_off                        | CPU board LED3 turn off   |
| <b>File Name : r_rssk_touch_led.c</b>  |   |
| r_rssk_touch_led_test                  | Touch electrode board LED test pattern processing               |
| r_rssk_touch_led_control               | Touch electrode board LED control processing                    |



### 3.7 List of Peripheral Functions Used and Pins Used

Table 3-6 shows a list of used pins, and Table 3-7 shows a list of handling of unused pins in this sample software.

Table 3-6 List of used pins

| Pin No. | Pin Name      | I/O | Usage  |
|---------|---------------|-----|--|
| 13      | TS00          | I/O | CTS measurement  |
| 5       | TS01          | I/O |  |
| 11      | TS02          | I/O |  |
| 10      | TS03          | I/O |  |
| 9       | TS04          | I/O |  |
| 8       | TS05          | I/O |  |
| 7       | TS06          | I/O |  |
| 6       | TS07          | I/O |  |
| 36      | TS08          | I/O |  |
| 23      | TS09          | I/O |  |
| 24      | TS10          | I/O |  |
| 22      | TS11          | I/O |  |
| 21      | TS12          | I/O |  |
| 20      | TS13          | I/O |  |
| 19      | TS14          | I/O |  |
| 18      | TS15          | I/O |  |
| 17      | TS16          | I/O |  |
| 16      | TS17          | I/O |  |
| 15      | TS18          | I/O |  |
| 33      | TS19          | I/O |  |
| 30      | TS20          | I/O |  |
| 29      | TS21          | I/O |  |
| 28      | TS22          | I/O |  |
| 27      | TS23          | I/O |  |
| 26      | TS24          | I/O |  |
| 25      | TS25          | I/O |  |
| 14      | TS28          | I/O |  |
| 12      | TSCAP         | -   |  |
| 34      | TS27/RXD1     | I   | QE serial communication (SW4 : Left)   |
| 35      | TS26/TXD1     | O   |  |
| 1       | P60/SW3       | I   | LED control<br><br>SW6 : Right<br>-> SW2, SW3, LED2 and LED3 available<br>SW6 : Left<br>-> Self-Capacitance Buttons / Wheel / Slider Board LED available |
| 4       | P63/LED3      | O   |  |
| 32      | P20/LED ROW0  | O   |  |
| 31      | P21/LED ROW1  | O   |  |
| 38      | P41/LED ROW2  | O   |  |
| 37      | P120/LED ROW3 | O   |  |
| 45      | P121/LED COL0 | O   |  |
| 44      | P122/LED COL1 | O   |  |
| 3       | P62/LED COL2  | O   |  |
| 2       | P61/LED COL3  | O   |  |

Table 3-7 List of Handling of Unused Pins

| Pin No              | Pin Name   | I/O | Handling  |
|---------------------|------------|-----|---|
| 43                  | P137/INTP0 | I   | Connect the pin to GND via a register (10Kohm). |
| 46                  | REGC       | I   | Connect the pin to GND via a capacitor (1.0uF). |
| 48                  | VDD        | I   | Connect the pin to GND via a capacitor (0.1uF). |
| 47                  | VSS        | I   | Connect the pin to GND.                         |
| Pins than the above |            | -   | Low output                                      |

Table 3-8 shows a list of peripheral functions used.

**Table 3-8 List of Peripheral Functions Used**

| Peripheral Function | Usage                                  |
|---------------------|--|
| CTSU                | CTSU measurement                       |
| UART1               | QE serial monitoring and serial tuning |
| TAU0                | LED control trigger                    |
| PORT                | LED control                            |

The peripheral function settings using Smart Configurator are shown below.

- UART communication

Use UART1 for serial monitoring of QE for Capacitive Touch. Table 3-9 shows the UART1 settings.

**Table 3-9 UART1 Setting**

| Item                                | Setting  |
|-------------------------------------|--|
| Operation Clock                     | CK00   |
| Clock Source                        | fCLK/2 <sup>4</sup>                                |
| Transfer mode setting               | Single transfer mode                               |
| Usable channel                      | UART1  |
| Transfer rate setting               | 115200 bps   |
| Callback function setting: Transmit | Transmission end : Enable                          |
| Callback function setting : Receive | Reception end : Enable<br>Reception error : Enable |

- Interval Timer

Use TAU0 for LED control. Table 3-10 shows the TAU0 settings.

**Table 3-10 TAU0 Setting**

| Item                     | Setting   |
|--------------------------|---|
| Operation Clock          | CK00  |
| Clock Source             | fCLK/2 <sup>8</sup>   |
| Interval value (16 bits) | 5 ms  |
| Interrupt setting        | End of timer channel0 count, generate an interrupt(INTTM00)<br>: Enable |

- Touch middleware.(rm\_touch)

Use rm\_touch for touch control. Table 3-11 shows the rm\_touch settings. This setting enables QE serial monitoring and serial tuning.

**Table 3-11 Touch middleware.(rm\_touch) Setting**

| Item                          | Setting |
|-------------------------------|---------|
| Support QE monitor using UART | Enable  |
| Support QE tuning using UART  | Enable  |
| UART channel                  | UART1   |

### 3.8 Processing Flowchart

Figure 3-2 shows processing flowchart of this sample code.

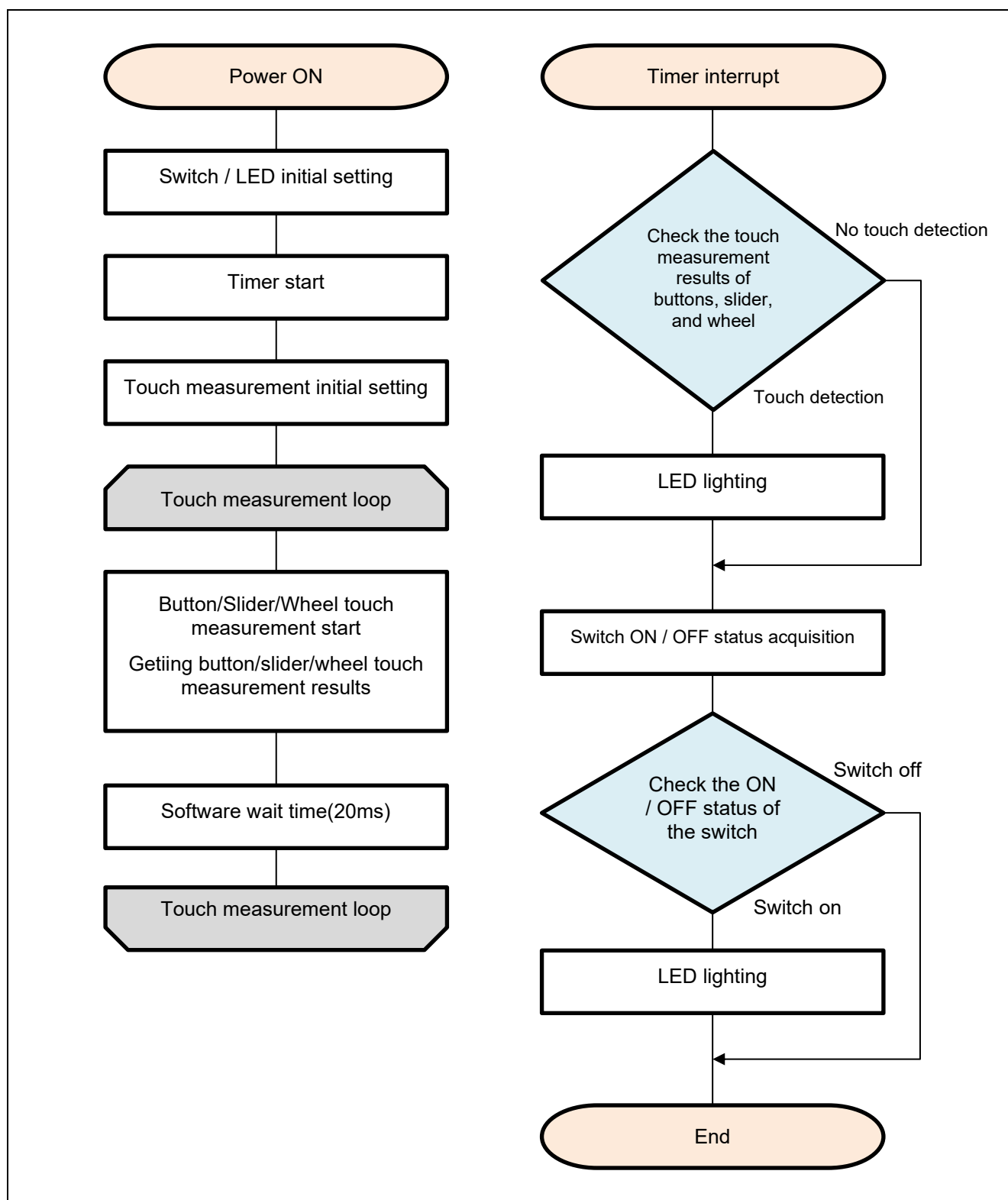


Figure 3-2 Processing Flowchart (Self-Capacitance Buttons / Wheel / Slider Board)

4. Capacitive Touch Setting

These are the touch interface configuration, configuration (method) settings and tuning results of this sample code. These use the tuning function of QE.

4.1 Touch Interface Configuration

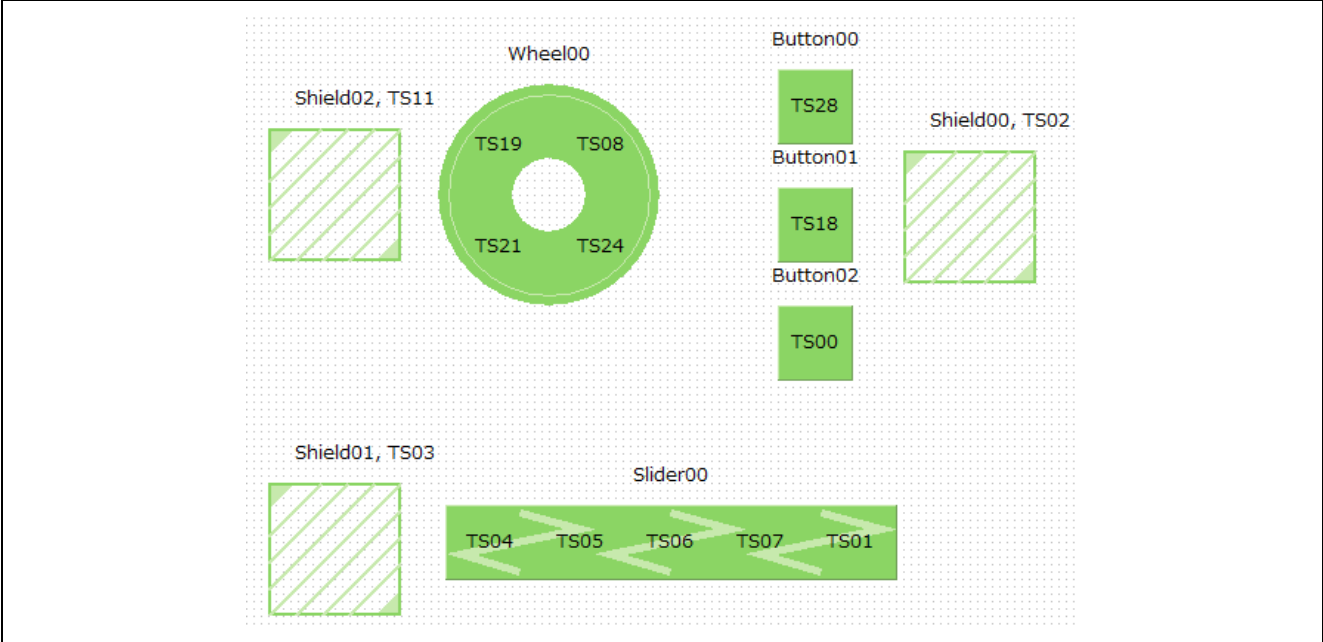


Figure 4-1 Touch interface configuration (Self-Capacitance Buttons / Wheel / Slider Board)

4.2 Configuration (methods) Settings

“config01” assigns 3 buttons and a shield(TS02). “config02” assigns slider and a shield(TS03). “config03” assigns wheel and a shield(TS11).

|   |   |   |   |  |
|---|---|---|---|--|
| <input type="checkbox"/> config01 <input type="checkbox"/> config02 <input type="checkbox"/> config03                         |   |   |   |  |
| Button00(self)  | <input checked="" type="checkbox"/> Available | <input type="checkbox"/>                      | <input type="checkbox"/>                      |  |
| Button01(self)  | <input checked="" type="checkbox"/> Available | <input type="checkbox"/>                      | <input type="checkbox"/>                      |  |
| Button02(self)  | <input checked="" type="checkbox"/> Available | <input type="checkbox"/>                      | <input type="checkbox"/>                      |  |
| Slider00(self)  | <input type="checkbox"/>                      | <input checked="" type="checkbox"/> Available | <input type="checkbox"/>                      |  |
| Wheel00(self)   | <input type="checkbox"/>                      | <input type="checkbox"/>                      | <input checked="" type="checkbox"/> Available |  |
| Shield00(self)  | <input checked="" type="checkbox"/> Available | <input type="checkbox"/>                      | <input type="checkbox"/>                      |  |
| Shield01(self)  | <input type="checkbox"/>                      | <input checked="" type="checkbox"/> Available | <input type="checkbox"/>                      |  |
| Shield02(self)  | <input type="checkbox"/>                      | <input type="checkbox"/>                      | <input checked="" type="checkbox"/> Available |  |
| Multiple Electrode Connection <input type="checkbox"/> Enable <input type="checkbox"/> Enable <input type="checkbox"/> Enable |   |   |   |  |

Figure 4-2 Configuration (methods) setting

### 4.3 Tuning results

Table 4-1 shows tuning results in QE tuning. Sample code operates with the setting values shown in the QE tuning result list.

Since the values in QE tuning result list depend on the operating environment at QE tuning, these values may change at QE tuning again.

**Table 4-1 QE tuning result list (Self-Capacitance Buttons / Wheel / Slider Board)**

| methods  | Button name | Touch sensor | Parasitic capacitance [pF] | Drive pulse frequency [MHz] | Threshold | Scan time [ms] | so    | snum | sdpa |
|----------|-------------|--------------|----------------------------|-----------------------------|-----------|----------------|-------|------|------|
| config01 | Button00    | TS28         | 9.533                      | 1 (BASE:1.0)                | 522       | 0.576          | 0x027 | 0x07 | 0x0F |
| config01 | Button01    | TS18         | 9.299                      | 1 (BASE:1.0)                | 531       | 0.576          | 0x024 | 0x07 | 0x0F |
| config01 | Button02    | TS00         | 9.708                      | 1 (BASE:1.0)                | 531       | 0.576          | 0x029 | 0x07 | 0x0F |
| config01 | Shield00    | TS02         | 45.479                     | -                           | -         | -              | -     | -    | -    |
| config02 | Slider00    | TS04         | 8.236                      | 1 (BASE:1.0)                | 497       | 0.576          | 0x026 | 0x07 | 0x0F |
| config02 | Slider00    | TS05         | 7.771                      | 1 (BASE:1.0)                | 497       | 0.576          | 0x01B | 0x07 | 0x0F |
| config02 | Slider00    | TS06         | 7.944                      | 1 (BASE:1.0)                | 497       | 0.576          | 0x015 | 0x07 | 0x0F |
| config02 | Slider00    | TS07         | 8.111                      | 1 (BASE:1.0)                | 497       | 0.576          | 0x018 | 0x07 | 0x0F |
| config02 | Slider00    | TS01         | 9.486                      | 1 (BASE:1.0)                | 497       | 0.576          | 0x01A | 0x07 | 0x0F |
| config02 | Shield01    | TS03         | 46.236                     | -                           | -         | -              | -     | -    | -    |
| config03 | Wheel00     | TS19         | 9.326                      | 1 (BASE:1.0)                | 637       | 0.576          | 0x02B | 0x07 | 0x0F |
| config03 | Wheel00     | TS08         | 9.826                      | 1 (BASE:1.0)                | 637       | 0.576          | 0x025 | 0x07 | 0x0F |
| config03 | Wheel00     | TS24         | 9.236                      | 1 (BASE:1.0)                | 637       | 0.576          | 0x02C | 0x07 | 0x0F |
| config03 | Wheel00     | TS21         | 10.16                      | 1 (BASE:1.0)                | 637       | 0.576          | 0x024 | 0x07 | 0x0F |
| config03 | Shield02    | TS11         | 41.083                     | -                           | -         | -              | -     | -    | -    |

so : Variables for sensor offset settings

snum : Variables for setting the measurement period

sdpa : Clock division setting variable

## 4.4 Sensitivity adjustment

Button sensitivity adjustment uses QE for Capacitive Touch. The sensitivity adjustment method is as follows.

- The method using monitoring function of QE for Capacitive Touch

Follow the tutorial from the "CapTouch Workflow (QE)" of QE for Capacitive Touch.

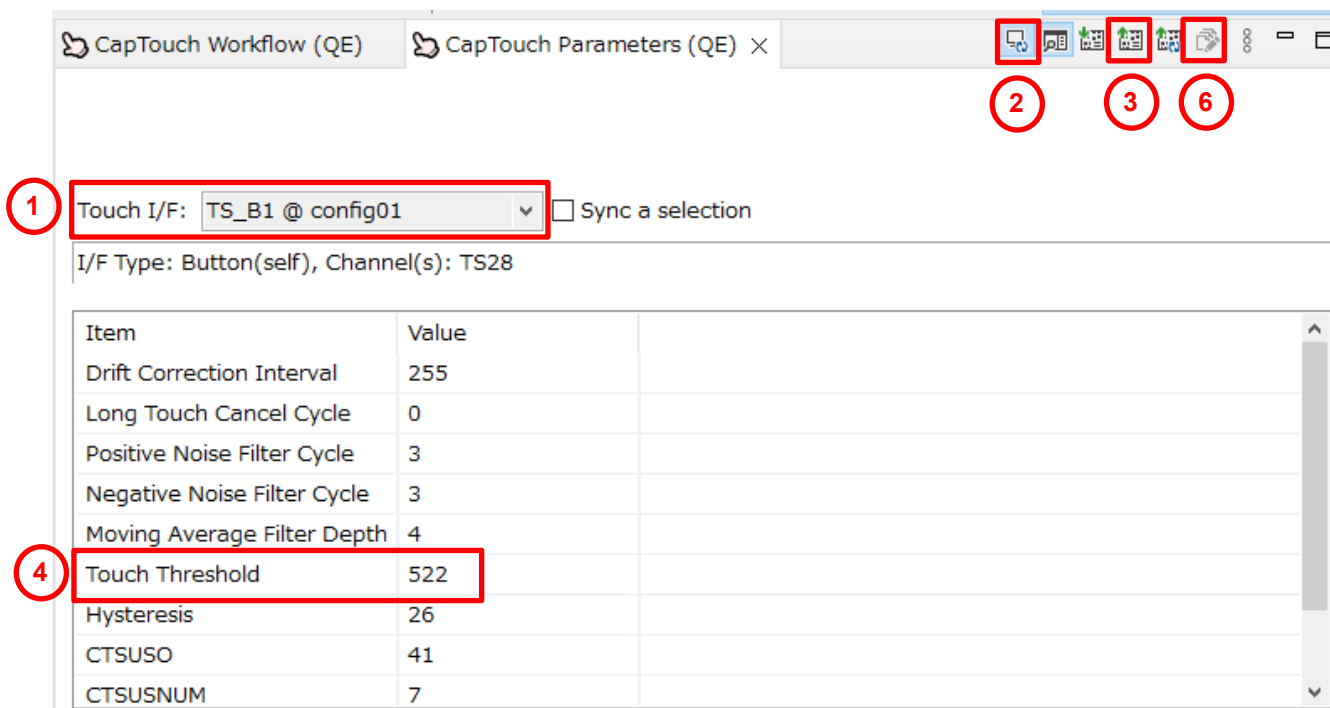
- Real-time change method using monitoring function of QE for Capacitive Touch

Display the Cap Touch parameter list of QE for Capacitive Touch and adjust it by the following steps.

1. Select the touch I/F corresponding to the button you want to adjust.
2. Click [Enable Monitoring] icon to start monitoring.  
When monitoring is enabled, the CapTouch parameter item is displayed.
3. Click [Write Value to the Target Board] to enable.
4. Change the value of [Touch Threshold].
5. Repeat steps 4 to adjust the sensitivity.

After completing the sensitivity adjustment, reflect the adjustment result in the source code by the following steps.

6. Click [Output Parameter Files] to generate the parameter file.
7. Build the project using the IDE (e<sup>2</sup> studio as an example).
8. Write the program to the MCU using the IDE (e<sup>2</sup> studio as an example).



- How to change the code manually

It can be adjusted by changing member variables of structure variable `g_qe_touch_button_cfg_config01` to 03.

The variables to change are:

- threshold : Touch detection threshold

## 5. Support

For information on capacitive touch, download tools and documentation, and technical support, please visit the website below

RL78/G22 Capacitive Touch Evaluation System <https://www.renesas.com/rssk-touch-rl78g22>

Application Note RL78 Family Using QE and SIS to Develop Capacitive Touch Applications (R01AN5512)  
[renesas.com/en/document/apn/rl78-family-using-qe-and-sis-develop-capacitive-touch-applications](https://www.renesas.com/en/document/apn/rl78-family-using-qe-and-sis-develop-capacitive-touch-applications)

QE for Capacitive Touch [renesas.com/qe-capacitive-touch](https://www.renesas.com/qe-capacitive-touch)

Renesas support [renesas.com/support](https://www.renesas.com/support)

**Revision History**

| Rev. | Date        | Description |                      |
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# General Precautions in the Handling of Microprocessing Unit and Microcontroller Unit Products

The following usage notes are applicable to all Microprocessing unit and Microcontroller unit products from Renesas. For detailed usage notes on the products covered by this document, refer to the relevant sections of the document as well as any technical updates that have been issued for the products.

## 1. Precaution against Electrostatic Discharge (ESD)

A strong electrical field, when exposed to a CMOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop the generation of static electricity as much as possible, and quickly dissipate it when it occurs. Environmental control must be adequate. When it is dry, a humidifier should be used. This is recommended to avoid using insulators that can easily build up static electricity.

Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work benches and floors must be grounded. The operator must also be grounded using a wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions must be taken for printed circuit boards with mounted semiconductor devices.

## 2. Processing at power-on

The state of the product is undefined at the time when power is supplied. The states of internal circuits in the LSI are indeterminate and the states of register settings and pins are undefined at the time when power is supplied. In a finished product where the reset signal is applied to the external reset pin, the states of pins are not guaranteed from the time when power is supplied until the reset process is completed. In a similar way, the states of pins in a product that is reset by an on-chip power-on reset function are not guaranteed from the time when power is supplied until the power reaches the level at which resetting is specified.

## 3. Input of signal during power-off state

Do not input signals or an I/O pull-up power supply while the device is powered off. The current injection that results from input of such a signal or I/O pull-up power supply may cause malfunction and the abnormal current that passes in the device at this time may cause degradation of internal elements. Follow the guideline for input signal during power-off state as described in your product documentation.

## 4. Handling of unused pins

Handle unused pins in accordance with the directions given under handling of unused pins in the manual. The input pins of CMOS products are generally in the high-impedance state. In operation with an unused pin in the open-circuit state, extra electromagnetic noise is induced in the vicinity of the LSI, an associated shoot-through current flows internally, and malfunctions occur due to the false recognition of the pin state as an input signal become possible.

## 5. Clock signals

After applying a reset, only release the reset line after the operating clock signal becomes stable. When switching the clock signal during program execution, wait until the target clock signal is stabilized. When the clock signal is generated with an external resonator or from an external oscillator during a reset, ensure that the reset line is only released after full stabilization of the clock signal. Additionally, when switching to a clock signal produced with an external resonator or by an external oscillator while program execution is in progress, wait until the target clock signal is stable.

## 6. Voltage application waveform at input pin

Waveform distortion due to input noise or a reflected wave may cause malfunction. If the input of the CMOS device stays in the area between  $V_{IL}$  (Max.) and  $V_{IH}$  (Min.) due to noise, for example, the device may malfunction. Take care to prevent chattering noise from entering the device when the input level is fixed, and also in the transition period when the input level passes through the area between  $V_{IL}$  (Max.) and  $V_{IH}$  (Min.).

## 7. Prohibition of access to reserved addresses

Access to reserved addresses is prohibited. The reserved addresses are provided for possible future expansion of functions. Do not access these addresses as the correct operation of the LSI is not guaranteed.

## 8. Differences between products

Before changing from one product to another, for example to a product with a different part number, confirm that the change will not lead to problems. The characteristics of a microprocessing unit or microcontroller unit products in the same group but having a different part number might differ in terms of internal memory capacity, layout pattern, and other factors, which can affect the ranges of electrical characteristics, such as characteristic values, operating margins, immunity to noise, and amount of radiated noise. When changing to a product with a different part number, implement a system-evaluation test for the given product.

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